SN74ALB16244 16-BIT BUFFER/DRIVER WITH 3-STATE OUTPUTS

SCBS647D - AUGUST 1995 - REVISED JANUARY 2001

- Member of Texas Instruments' Widebus™ Family
- State-of-the-Art Advanced Low-Voltage BiCMOS (ALB) Technology Design for 3.3-V Operation
- Schottky Diodes on All Inputs to Eliminate Overshoot and Undershoot
- Industry Standard '16244 Pinout
- Distributed V_{CC} and GND Pins Minimize High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout

description

The SN74ALB16244 16-bit buffer and line driver is designed for high-speed, low-voltage (3.3-V)V_{CC} operation. This device is intended to replace the conventional driver in any speed-critical path. The small propagation delay is achieved using a unity-gain amplifier on the input and feedback resistors from input to output, which allows the output to track the input with a small offset voltage.

The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. This device provides true outputs and symmetrical active-low output-enable (\overline{OE}) inputs.

DGG, DGV, OR DL PACKAGE (TOP VIEW)						
10E 1Y1 [1Y2 [GND [1Y3 [1Y4 [2Y1 [2Y2 [GND [2Y3 [3Y2 [GND [3Y3 [3Y4 [3Y4 [3Y4 [4Y1]	(TOP VII) 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19	EW) 48 20E 47 1A1 46 1A2 45 GND 44 1A3 43 1A4 42 V _{CC} 41 2A1 40 2A2 39 GND 38 2A3 37 2A4 36 3A1 35 3A2 34 GND 33 2A3 32 3A4 31 V _{CC} 30 4A1				
4Y2 [GND [20 21	29 4A2 28 GND				
4Y3 [4Y4 [27] 4A3 26] 4A4				
40E [24	25 30E				

ORDERING INFORMATION

TA	PACKAGE [†]		ORDERABLE PART NUMBER	TOP-SIDE MARKING
40%0 to 05%0	SSOP – DL	Tube	SN74ALB16244DL	ALB16244
	330F - DL	Tape and reel	SN74ALB16244DLR	ALD10244
–40°C to 85°C	TSSOP – DGG Tape and reel		SN74ALB16244DGGR	ALB16244
	TVSOP – DGV	Tape and reel	SN74ALB16244DGVR	AV244

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE (each buffer)

INPUTS		OUTPUT
OE	Α	Y
L	Н	Н
L	L	L
н	Х	Z



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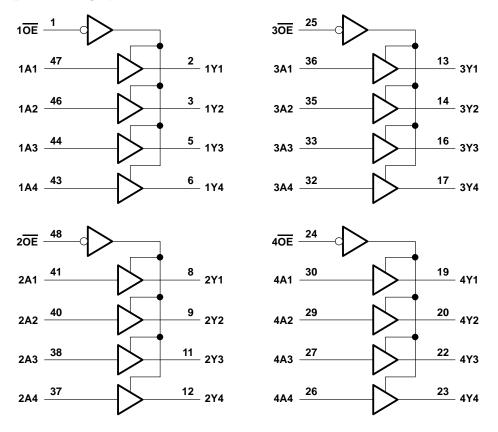
logic symbol[†]

1 <mark>0E</mark>	1	EN1				
2 <mark>0E</mark>	48	EN2				
3 <mark>0E</mark>	25	EN3				
4 <u>0</u> E	24	EN4				
40E				لے		
1A1	47	┎┺━━	1	1 🗸	2	1Y1
1A2	46	<u> </u>	•	1 V	3	1Y2
1A3	44				5	1Y3
1A3	43				6	1Y4
	41		4	2 ▽	8	
2A1	40		1	2 ∨	9	2Y1
2A2	38	 			11	2Y2
2A3	37	<u> </u>			12	2Y3
2A4	36			- 57	13	2Y4
3A1	35		1	3 ♡	14	3Y1
3A2	33				16	3Y2
3A3	32				17	3Y3
3A4	30				19	3Y4
4A1	29		1	4 ▽	20	4Y1
4A2	27				22	4Y2
4A3	26				22	4Y3
4A4					25	4Y4

 † This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 4.6 V
Input voltage range, VI: Except I/O ports (see Note 1)	
I/O ports (see Notes 1 and 2)	–0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Notes 1 and 2)	\dots –0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0)	
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, I_{O} (V _O = 0 to V _{CC})	±50 mA
Continuous current through each V _{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 3): DGG package	
DGV package	
DL package	
Storage temperature range, T _{stg}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

- 2. This value is limited to 4.6 V maximum.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.



recommended operating conditions

			MIN	MAX	UNIT
VCC	V _{CC} Supply voltage				V
юн†	I _{OH} [†] High-level output current				mA
IOL [†]	Low-level output current				mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		5	ns/V
ТĄ	Operating free-air temperature		-40	85	°C

[†] See Figures 1 and 2 for typical I/O ranges.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

P/	ARAMETER		TEST CONDITION	NS	MIN	TYP‡	MAX	UNIT
		V _{CC} = 3 V	lı = 18 mA	lj = 18 mA		3.6	V _{CC} -1.2	V
VIК	Data inputs	vCC = 3 v	lı = -18 mA	l _l = –18 mA		-0.9	-1.2	v
	Control inputs	V _{CC} = 3.6 V,	$V_I = V_{CC} \text{ or } GND$				±10	μA
				OE low		0.4	0.6	mA
Ц	Data inputa	inputs $V_{CC} = 3.6 V$	$V_I = V_{CC}$	OE high			25	μA
Data	Data inputs		V _I = 0	OE low		-0.8	-1	mA
				OE high			-60	μA
IOZH		V _{CC} = 3.6 V,	V _O = 3 V			0.6	20	μΑ
IOZL		V _{CC} = 3.6 V,	$V_{O} = 0.5 V$			-0.1	-50	μA
ICC/p	uffer	V _{CC} = 3.6 V,	IO = 0,	$V_I = V_{CC} \text{ or } GND$		3.7	5.6	mA
ICCZ		V _{CC} = 3.6 V,	Control inputs = V	Control inputs = V _{CC} or GND			0.8	mA
ΔI_{CC} V _{CC} = 3 V to 3.6 V, One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND				600	μA			
Ci		V _I = 3 V or 0				4.5		pF
Co		V _O = 3 V or 0				5.5		pF

[‡] All typical values are at V_{CC} = 3.3 V, T_A = 25°C. § This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 3)

PARAMETER	FROM	то	$V_{\mbox{CC}}$ = 3.3 V \pm 0.3 V			UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP‡	MAX	UNIT
^t pd	А	Y	0.6	1.3	2	ns
ten	OE	Y	1.3	2.5	4.7	ns
^t dis	OE	Y	1.8	2.8	4.2	ns

[‡] All typical values are at V_{CC} = 3.3 V, T_A = 25° C.



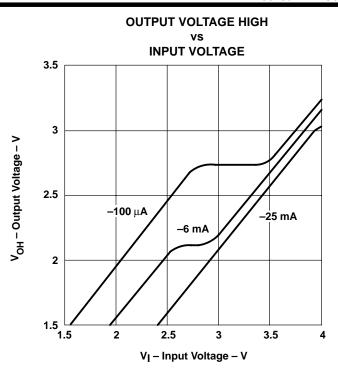


Figure 1. V_{OH} Over Recommended Free-Air Temperature Range

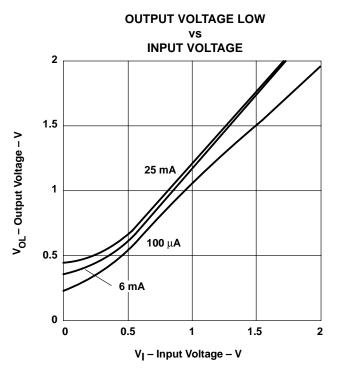
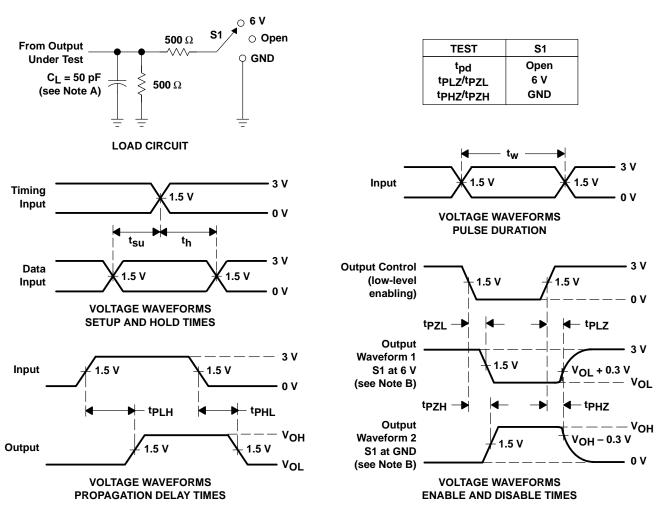


Figure 2. V_{OL} Over Recommended Free-Air Temperature Range



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PARAMETER MEASUREMENT INFORMATION

- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_r \leq 2.5 ns, t_f \leq 2.5 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpLz and tpHz are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tPLH and tPHL are the same as tpd.

Figure 3. Load Circuit and Voltage Waveforms



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